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What is "Embedded - Microcontrollers"?

"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "<u>Embedded -</u> <u>Microcontrollers</u>"

Details

Product Status	Discontinued at Digi-Key
Core Processor	ARM® Cortex®-M0+
Core Size	32-Bit Single-Core
Speed	30MHz
Connectivity	I ² C, SPI, UART/USART
Peripherals	Brown-out Detect/Reset, Cap Sense, DMA, POR, PWM, WDT
Number of I/O	42
Program Memory Size	64KB (64K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	8K x 8
Voltage - Supply (Vcc/Vdd)	1.8V ~ 3.6V
Data Converters	A/D 12x12b
Oscillator Type	External, Internal
Operating Temperature	-40°C ~ 105°C (TA)
Mounting Type	Surface Mount
Package / Case	48-LQFP
Supplier Device Package	48-LQFP (7x7)
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/lpc844m201jbd48e

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Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong

- Supports In-System Programming (ISP) through USART, SPI, and I²C.
- ◆ FAIM API.
- ♦ FRO API.
- On-chip ROM APIs for integer divide.
- Digital peripherals:
 - High-speed GPIO interface connected to the Arm Cortex-M0+ I/O bus with up to 54 General-Purpose I/O (GPIO) pins with configurable pull-up/pull-down resistors, programmable open-drain mode, input inverter, and digital filter. GPIO direction control supports independent set/clear/toggle of individual bits.
 - ◆ High-current source output driver (20 mA) on four pins.
 - ◆ High-current sink driver (20 mA) on two true open-drain pins.
 - GPIO interrupt generation capability with boolean pattern-matching feature on eight GPIO inputs.
 - Switch matrix for flexible configuration of each I/O pin function.
 - ◆ CRC engine.
 - ◆ DMA with 25 channels and 13 trigger inputs.
 - ◆ Capacitive Touch Interface.
- Timers:
 - One SCTimer/PWM with five input and seven output functions (including capture and match) for timing and PWM applications. Inputs and outputs can be routed to or from external pins and internally to or from selected peripherals. Internally, the SCTimer/PWM supports 8 match/captures, 8 events, and 8 states.
 - One 32-bit general purpose counter/timer, with four match outputs and three capture inputs. Supports PWM mode, external count, and DMA.
 - Four channel Multi-Rate Timer (MRT) for repetitive interrupt generation at up to four programmable, fixed rates.
 - Self-Wake-up Timer (WKT) clocked from either Free Running Oscillator (FRO), a low-power, low-frequency internal oscillator, or an external clock input in the always-on power domain.
 - Windowed Watchdog timer (WWDT).
- Analog peripherals:
 - One 12-bit ADC with up to 12 input channels with multiple internal and external trigger inputs and with sample rates of up to 1.2 Msamples/s. The ADC supports two independent conversion sequences.
 - Comparator with five input pins and external or internal reference voltage.
 - ♦ Two 10-bit DACs.
- Serial peripherals:
 - Five USART interfaces with pin functions assigned through the switch matrix and two fractional baud rate generators.
 - ◆ Two SPI controllers with pin functions assigned through the switch matrix.
 - Four I²C-bus interfaces. One I²C supports Fast-mode Plus with 1 Mbit/s data rates on two true open-drain pins and listen mode. Three I²Cs support data rates up to 400 kbit/s on standard digital pins.
- Clock generation:

4. Ordering information

Table 1.Ordering information

Type number	Package	Package						
	Name	Description	Version					
LPC845M301JBD64	LQFP64	Plastic low profile quad flat package; 64 leads; body $10 \times 10 \times 1.4$ mm	SOT314-2					
LPC845M301JBD48	LQFP48	Plastic low profile quad flat package; 48 leads; body $7 \times 7 \times 1.4$ mm	SOT313-2					
LPC845M301JHI48	HVQFN48	HVQFN: plastic thermal enhanced very thin quad flat package; no leads; 48 terminals; body $7 \times 7 \times 0.85$ mm	SOT619-1					
LPC845M301JHI33	HVQFN33	HVQFN: plastic thermal enhanced very thin quad flat package; no leads; 33 terminals; body $5 \times 5 \times 0.85$ mm	SOT617-11					
LPC844M201JBD64	LQFP64	Plastic low profile quad flat package; 64 leads; body $10 \times 10 \times 1.4$ mm	SOT314-2					
LPC844M201JBD48	LQFP48	Plastic low profile quad flat package; 48 leads; body $7 \times 7 \times 1.4$ mm	SOT313-2					
LPC844M201JHI48	HVQFN48	HVQFN: plastic thermal enhanced very thin quad flat package; no leads; 48 terminals; body 7 \times 7 \times 0.85 mm	SOT619-1					
LPC844M201JHI33	HVQFN33	HVQFN: plastic thermal enhanced very thin quad flat package; no leads; 33 terminals; body $5 \times 5 \times 0.85$ mm	SOT617-11					

4.1 Ordering options

Table 2.Ordering options

Type number	Flash/KB	SRAM/KB	USART	I ² C	SPI	DAC	Capacitive Touch	GPIO	Package
LPC845M301JBD64	64	16	5	4	2	2	yes	54	LQFP64
LPC845M301JBD48	64	16	5	4	2	2	yes	42	LQFP48
LPC845M301JHI48	64	16	5	4	2	2	yes	42	HVQFN48
LPC845M301JHI33	64	16	5	4	2	1	-	29	HVQFN33
LPC844M201JBD64	64	8	2	2	2	-	-	54	LQFP64
LPC844M201JBD48	64	8	2	2	2	-	-	42	LQFP48
LPC844M201JHI48	64	8	2	2	2	-	-	42	HVQFN48
LPC844M201JHI33	64	8	2	2	2	-	-	29	HVQFN33

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Block diagram 6.



7. Pinning information

7.1 Pinning



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7.2 Pin description

The pin description table shows the pin functions that are fixed to specific pins on each package. See <u>Table 4</u>. These fixed-pin functions are selectable through the switch matrix between GPIO and the comparator, ADC, SWD, RESET, and the XTAL pins. By default, the GPIO function is selected except on pins PIO0_2, PIO0_3, and PIO0_5. JTAG functions are available in boundary scan mode only.

Movable functions for the I²C, USART, SPI, CTimer, SCT pins, and other peripherals can be assigned through the switch matrix to any pin that is not power or ground in place of the pin's fixed functions.

The following exceptions apply:

Do not assign more than one output to any pin. However, an output and/or one or more inputs can be assigned to a pin. Once any function is assigned to a pin, the pin's GPIO functionality is disabled.

Pin PIO0_4 triggers a wake-up from deep power-down mode. If the part must wake up from deep power-down mode via an external pin, do not assign any movable function to this pin.

8.10 Switch Matrix (SWM)

The switch matrix controls the function of each digital or mixed analog/digital pin in a highly flexible way by allowing to connect many functions, for example, the USART, SPI, SCTimer/PWM, CTimer, and I²C functions to any pin that is not power or ground. These functions are called movable functions and are listed in Table 5.

Functions that need specialized pads like the oscillator pins XTALIN and XTALOUT can be enabled or disabled through the switch matrix. These functions are called fixed-pin functions and cannot move to other pins. The fixed-pin functions are listed in <u>Table 4</u>. If a fixed-pin function is disabled, any other movable function can be assigned to this pin.

8.11 Fast General-Purpose parallel I/O (GPIO)

Device pins that are not connected to a specific peripheral function are controlled by the GPIO registers. Pins may be dynamically configured as inputs or outputs. Multiple outputs can be set or cleared in one write operation.

LPC84x use accelerated GPIO functions:

- GPIO registers are on the Arm Cortex-M0+ IO bus for fastest possible single-cycle I/O timing, allowing GPIO toggling with rates of up to 15 MHz.
- An entire port value can be written in one instruction.
- Mask, set, and clear operations are supported for the entire port.

All GPIO port pins are fixed-pin functions that are enabled or disabled on the pins by the switch matrix. Therefore each GPIO port pin is assigned to one specific pin and cannot be moved to another pin. Except for pins SWDIO/PIO0_2, SWCLK/PIO0_3, and RESET/PIO0_5, the switch matrix enables the GPIO port pin function by default.

8.11.1 Features

- Bit level port registers allow a single instruction to set and clear any number of bits in one write operation.
- Direction control of individual bits.
- All I/O default to GPIO inputs with internal pull-up resistors enabled after reset except for the I²C-bus true open-drain pins PIO0_10 and PIO0_11.
- Pull-up/pull-down configuration, repeater, and open-drain modes can be programmed through the IOCON block for each GPIO pin (see <u>Figure 9</u>).
- Direction (input/output) can be set and cleared individually.
- Pin direction bits can be toggled.

8.12 Pin interrupt/pattern match engine

The pin interrupt block configures up to eight pins from all digital pins for providing eight external interrupts connected to the NVIC.

The pattern match engine can be used, with software, to create complex state machines based on pin inputs.

- Data frames of 1 to 16 bits supported directly. Larger frames supported by software.
- Master and slave operation.
- Data can be transmitted to a slave without the need to read incoming data, which can be useful while setting up an SPI memory.
- Control information can optionally be written along with data, which allows very versatile operation, including "any length" frames.
- One Slave Select input/output with selectable polarity and flexible usage.

Remark: Texas Instruments SSI and National Microwire modes are not supported.

8.16 I²C-bus interface (I²C0/1/2/3)

The I²C-bus is bidirectional for inter-IC control using only two wires: a serial clock line (SCL) and a serial data line (SDA). Each device is recognized by a unique address and can operate as either a receiver-only device (for example, an LCD driver) or a transmitter with the capability to both receive and send information (such as memory). Transmitters and/or receivers can operate in either master or slave mode, depending on whether the chip has to initiate a data transfer or is only addressed. The I²C is a multi-master bus and can be controlled by more than one bus master.

The I2C0-bus functions are fixed-pin functions. All other I2C-bus functions for I2C1/2/3 are movable functions and can be assigned through the switch matrix to any pin. However, only the true open-drain pins provide the electrical characteristics to support the full I2C-bus specification (see <u>Ref. 3</u>).

8.16.1 Features

- I2C0 supports Fast-mode Plus with data rates of up to 1 Mbit/s in addition to standard and fast modes on two true open-drain pins.
- True open-drain pins provide fail-safe operation: When the power to an I²C-bus device is switched off, the SDA and SCL pins connected to the I²C0-bus are floating and do not disturb the bus.
- I2C1/2/3 support standard and fast mode with data rates of up to 400 kbit/s.
- Independent Master, Slave, and Monitor functions.
- Supports both Multi-master and Multi-master with Slave functions.
- Multiple I²C slave addresses supported in hardware.
- One slave address can be selectively qualified with a bit mask or an address range in order to respond to multiple I²C bus addresses.
- 10-bit addressing supported with software assist.
- Supports SMBus.

8.17 Capacitive Touch Interface

The Capacitive Touch interface is designed to handle up to nine capacitive buttons in different sensor configurations, such as slider, rotary, and button matrix. It operates in sleep, deep sleep, and power-down modes, allowing very low power performance.

The Capacitive Touch module measures the change in capacitance of an electrode plate when an earth-ground connected object (for example, finger) is brought within close proximity.

8.18 SCTimer/PWM

The SCTimer/PWM can perform basic 16-bit and 32-bit timer/counter functions with match outputs and external and internal capture inputs. In addition, the SCTimer/PWM can employ up to eight different programmable states, which can change under the control of events, to provide complex timing patterns.

The inputs to the SCT are multiplexed between movable functions from the switch matrix and internal connections such as the ADC threshold compare interrupt, the comparator output, and the Arm core signals Arm_TXEV and DEBUG_HALTED. The signal on each SCT input is selected through the INPUT MUX.

All outputs of the SCT are movable functions and are assigned to pins through the switch matrix. One SCT output can also be selected as one of the ADC conversion triggers.

8.18.1 Features

- Each SCTimer/PWM supports:
 - Eight match/capture registers.
 - Eight events.
 - Eight states.
 - Five inputs. The fifth input is hard-wired to a clock source. Each input is configurable through an input multiplexer to use one of four external pins (connected through the switch matrix) or one of four internal sources. The maximum input signal frequency is 25 MHz.
 - Six outputs. Connected to pins through the switch matrix.
- Counter/timer features:
 - Each SCTimer is configurable as two 16-bit counters or one 32-bit counter.
 - Counters can be clocked by the system clock or selected input.
 - Configurable as up counters or up-down counters.
 - Configurable number of match and capture registers. Up to eight match and capture registers total.
 - Upon match create the following events: interrupt; stop, limit, halt the timer or change counting direction; toggle outputs.
 - Counter value can be loaded into capture register triggered by a match or input/output toggle.
- PWM features:
 - Counters can be used with match registers to toggle outputs and create time-proportioned PWM signals.
 - Up to six single-edge or dual-edge PWM outputs with independent duty cycle and common PWM cycle length.
- Event creation features:

The ADC includes a hardware threshold compare function with zero-crossing detection.

Remark: For best performance, select VREFP and VREFN at the same voltage levels as V_{DD} and V_{SS} . When selecting VREFP and VREFN different from VDD and VSS, ensure that the voltage midpoints are the same:

 $(VREFP-VREFN)/2 + VREFN = V_{DD}/2$

8.24.1 Features

- 12-bit successive approximation analog to digital converter.
- 12-bit conversion rate of up to 1.2 MSamples/s.
- Two configurable conversion sequences with independent triggers.
- Optional automatic high/low threshold comparison and zero-crossing detection.
- Power-down mode and low-power operating mode.
- Measurement range VREFN to VREFP (not to exceed V_{DD} voltage level).
- Burst conversion mode for single or multiple inputs.
- Hardware calibration mode.

8.25 Digital-to-Analog Converter (DAC)

The DAC supports a resolution of 10 bits. Conversions can be triggered by an external pin input or an internal timer.

The DAC includes an optional automatic hardware shut-off feature which forces the DAC output voltage to zero while a HIGH level on the external DAC_SHUTOFF pin is detected.

8.25.1 Features

- 10-bit digital-to-analog converter.
- Supports DMA.
- Internal timer or pin external trigger for staged, jitter-free DAC conversion sequencing.
- Automatic hardware shut-off triggered by an external pin.

8.26 CRC engine

The Cyclic Redundancy Check (CRC) generator with programmable polynomial settings supports several CRC standards commonly used. To save system power and bus bandwidth, the CRC engine supports DMA transfers.

8.26.1 Features

- Supports three common polynomials CRC-CCITT, CRC-16, and CRC-32.
 - CRC-CCITT: x¹⁶ + x¹² + x⁵ + 1
 - CRC-16: x¹⁶ + x¹⁵ + x² + 1
 - CRC-32: $x^{32} + x^{26} + x^{23} + x^{22} + x^{16} + x^{12} + x^{11} + x^{10} + x^8 + x^7 + x^5 + x^4 + x^2 + x + 1$
- Bit order reverse and 1's complement programmable setting for input data and CRC sum.
- Programmable seed number setting.

11.4 Peripheral power consumption

The supply current per peripheral is measured as the difference in supply current between the peripheral block enabled and the peripheral block disabled in the SYSAHBCLKCFG and PDRUNCFG (for analog blocks) registers. All other blocks are disabled in both registers and no code accessing the peripheral is executed. Measured on a typical sample at T_{amb} = 25 °C.

The supply currents are shown for FRO clock frequencies of 12 MHz and 30 MHz.

Table 14. Power consumption for individual analog and digital blocks

Peripheral	Typical su	upply current in	μA	Notes		
	System c	lock frequency	=			
	n/a	12 MHz	30 MHz			
FRO	89	-	-	System oscillator running; PLL off; independent of main clock frequency; FRO = 24 MHz. FRO output disabled.		
System oscillator at 12 MHz	243	-	-	FRO running; PLL off; independent of main clock frequency.		
Watchdog oscillator	1	-	-	FRO; PLL off; independent of main clock frequency.		
BOD	42	-	-	Independent of main clock frequency.		
Flash	273	-	-	-		
Main PLL	156	-	-	FRO (24 MHz) running; Main clock running at fro_div (12 MHz)		
CLKOUT	-	25	61	Main clock divided by 4 in the CLKOUTDIV register. Not connected to pin.		
ROM	-	35	86	-		
GPIO + pin interrupt/pattern match	-	159	384	GPIO pins configured as outputs and set to LOW. Direction and pin state are maintained if the GPIO is disabled in the SYSAHBCLKCFG register.		
SWM	-	85	206	-		
IOCON	-	80	193	-		
SCTimer/PWM	-	172	419	-		
CTimer		51	123			
MRT	-	102	245	-		
WWDT	-	28	70	-		
I2C0	-	54	131	-		
I2C1	-	47	115	-		
I2C2	-	44	106	-		
I2C3	-	60	145	-		
SPI0	-	43	106	-		
SPI1	-	44	107	-		
USART0	-	53	128	-		
USART1	-	53	130	-		
USART2	-	46	90	-		

12.6 I²C-bus

Table 22.	Dynamic characteristic: I ² C-bus pins ^[1]
$T_{amb} = -40$	$^{\circ}$ C to +105 $^{\circ}$ C: values guaranteed by design. ^[2]

Symbol	Parameter		Conditions	Min	Max	Unit
f _{SCL}	SCL clock		Standard-mode	0	100	kHz
	frequency		Fast-mode	0	400	kHz
			Fast-mode Plus; on pins PIO0_10 and PIO0_11	0	1	MHz
t _f	fall time	<u>[4][5][6][7]</u>	of both SDA and SCL signals Standard-mode	-	300	ns
			Fast-mode	20 + 0.1 × C _b	300	ns
			Fast-mode Plus; on pins PIO0_10 and PIO0_11	-	120	ns
t _{LOW}	LOW period of		Standard-mode	4.7	-	μS
	the SCL clock		Fast-mode	1.3	-	μS
			Fast-mode Plus; on pins PIO0_10 and PIO0_11	0.5	-	μs
t _{HIGH} HIGH	HIGH period of		Standard-mode	4.0	-	μS
	the SCL clock		Fast-mode	0.6	-	μS
			Fast-mode Plus; on pins PIO0_10 and PIO0_11	0.26	-	μs
t _{HD;DAT}	data hold time	[3][4][8]	Standard-mode	0	-	μS
			Fast-mode	0	-	μS
			Fast-mode Plus; on pins PIO0_10 and PIO0_11	0	-	μs
t _{SU;DAT}	data set-up	[9][10]	Standard-mode	250	-	ns
	time		Fast-mode	100	-	ns
			Fast-mode Plus; on pins PIO0_10 and PIO0_11	50	-	ns

[1] See the I²C-bus specification UM10204 for details.

- [2] Parameters are valid over operating temperature range unless otherwise specified.
- [3] t_{HD;DAT} is the data hold time that is measured from the falling edge of SCL; applies to data in transmission and the acknowledge.
- [4] A device must internally provide a hold time of at least 300 ns for the SDA signal (with respect to the $V_{IH}(min)$ of the SCL signal) to bridge the undefined region of the falling edge of SCL.
- [5] C_b = total capacitance of one bus line in pF.
- [6] The maximum t_f for the SDA and SCL bus lines is specified at 300 ns. The maximum fall time for the SDA output stage t_f is specified at 250 ns. This allows series protection resistors to be connected in between the SDA and the SCL pins and the SDA/SCL bus lines without exceeding the maximum specified t_f.
- [7] In Fast-mode Plus, fall time is specified the same for both output stage and bus timing. If series resistors are used, designers should allow for this when considering bus timing.

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12.7 SPI interfaces

The actual SPI bit rate depends on the delays introduced by the external trace, the external device, system clock (CCLK), and capacitive loading. Excluding delays introduced by external device and PCB, the maximum supported bit rate for SPI master mode is 30 Mbit/s, and the maximum supported bit rate for SPI slave mode is $1/(2 \times 26 \text{ ns})$ = 19 Mbit/s at $3.0v \le \text{VDD} \le 3.6v$ and $1/(2 \times 42 \text{ ns})$ = 12 Mbit/s at $1.8v \le \text{VDD} < 3.0v$.

Remark: SPI functions can be assigned to all digital pins. The characteristics are valid for all digital pins except the open-drain pins PIO0_10 and PIO0_11.

Table 23. SPI dynamic characteristics

 $T_{amb} = -40 \ ^{\circ}C$ to 105 $^{\circ}C$; $C_L = 20 \ pF$; input slew = 1 ns. Simulated parameters sampled at the 30 % and 70 % level of the rising or falling edge; values guaranteed by design. Delays introduced by the external trace or external device are not considered.

Symbol	Parameter	Conditions	Min	Max	Unit
SPI mast	er			I	
t _{DS}	data set-up time	1.8 V <= V _{DD} <= 3.6 V	3	-	ns
t _{DH}	data hold time	1.8 V <= V _{DD} <= 3.6 V	0	-	ns
t _{v(Q)}	data output valid time	1.8 V <= V _{DD} <= 3.6 V	0	5	ns
SPI slave)			I	L
t _{DS}	data set-up time	1.8 V <= V _{DD} <= 3.6 V	4	-	ns
t _{DH}	data hold time	1.8 V <= V _{DD} <= 3.6 V	1	-	ns
t _{v(Q)}	data output valid time	3.0 V <= V _{DD} <= 3.6 V	0	26	ns
		1.8 V <= V _{DD} < 3.0 V	0	42	ns

13.2 ADC

Table 27. 12-bit ADC static characteristics

 $T_{amb} = -40$ °C to +105 °C unless noted otherwise; $V_{DD} = V_{DDA} = 2.4$ V to 3.6 V; VREFP = $V_{DD} = V_{DDA}$; VREFN = V_{SS} .

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V _{IA}	analog input voltage			0	-	V _{DDA}	V
V _{ref}	reference voltage	on pin VREFP		2.4	-	V _{DDA}	V
C _{ia}	analog input capacitance			-	-	26	pF
f _{clk(ADC)}	ADC clock frequency		[2]	-	-	30	MHz
f _s	sampling frequency		[2]	-	-	1.2	Msamples/s
E _D	differential linearity error		[5][4]	-	±3.0	-	LSB
E _{L(adj)}	integral non-linearity		[6][4]	-	±2.0	-	LSB
Eo	offset error		[7][4]	-	±3.5	-	LSB
V _{err(fs)}	full-scale error voltage		[8][4]	-	0.1	-	%
Zi	input impedance	f _s = 1.2 Msamples/s	[1][9][10]	0.1	-	-	MΩ

[1] The input resistance of ADC channel 0 is higher than for all other channels. See Figure 33.

[2] In the ADC TRM register, set VRANGE = 0 (default).

[3] In the ADC TRM register, set VRANGE = 1.

[4] Based on characterization. Not tested in production.

[5] The differential linearity error (E_D) is the difference between the actual step width and the ideal step width. See Figure 34.

[6] The integral non-linearity (E_{L(adj)}) is the peak difference between the center of the steps of the actual and the ideal transfer curve after appropriate adjustment of gain and offset errors. See <u>Figure 34</u>.

[7] The offset error (E_0) is the absolute difference between the straight line which fits the actual curve and the straight line which fits the ideal curve. See <u>Figure 34</u>.

[8] The full-scale error voltage or gain error (E_G) is the difference between the straight line fitting the actual transfer curve after removing offset error, and the straight line which fits the ideal transfer curve. See Figure 34.

[9] $T_{amb} = 25 \degree$ C; maximum sampling frequency f_s = 1.2 Msamples/s and analog input capacitance C_{ia} = 26 pF.

[10] Input impedance Z_i (See Section 13.2.1 "ADC input impedance") is inversely proportional to the sampling frequency and the total input capacity including C_{ia} and C_{io} : $Z_i \propto 1 / (f_s \times C_i)$. See Table 13 for C_{io} .

Table 29. 0	Comparator	characteristics	continued
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 $T_{amb} = -40$ °C to +105 °C unless noted otherwise; $V_{DD} = 1.8$ V to 3.6 V.

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
t _{PD}	propagation delay	HIGH to LOW; V _{DD} = 3.0 V; T _{amb} = 105 °C			150		
		V _{IC} = 0.1 V; 100 mV overdrive input	[1][2][4]	-		-	ns
		V _{IC} = 0.1 V; rail-to-rail input	[1][2]	-	250	-	ns
		V _{IC} = 1.5 V; 100 mV overdrive input	[1][2][4]	-	150	-	ns
		V _{IC} = 1.5 V; rail-to-rail input	[1][2]	-	170	-	ns
		V _{IC} = 2.9 V; 100 mV overdrive input	[1][2][4]	-	180	-	ns
		V _{IC} = 2.9 V; rail-to-rail input	[1][2]	-	70	-	ns
t _{PD}	propagation delay	LOW to HIGH; V_{DD} = 3.0 V; T_{amb} = 105 °C			260		
		V _{IC} = 0.1 V; 100 mV overdrive input	[1][2][4]	-		-	ns
		V _{IC} = 0.1 V; rail-to-rail input	[1][2]	-	90	-	ns
		V _{IC} = 1.5 V; 100 mV overdrive input	[1][2][4]	-	270	-	ns
		V _{IC} = 1.5 V; rail-to-rail input	[1][2]	-	220	-	ns
		V _{IC} = 2.9 V; 100 mV overdrive input	[1][2][4]	-	190	-	ns
		V _{IC} = 2.9 V; rail-to-rail input	[1][2]	-	700	-	ns
V _{hys}	hysteresis voltage	positive hysteresis; V_{DD} = 3.0 V; V_{IC} = 1.5 V; T_{amb} = 105 °C; settings:	[3]	-	6	-	
		5 mV					mV
		10 mV		-	12	-	mV
		20 mV		-	22	-	mV
V _{hys}	hysteresis voltage	negative hysteresis; V_{DD} = 3.0 V; V _{IC} = 1.5 V; T _{amb} = 105 °C; settings:	[1][3]		7		
		5 mV		-		-	mV
		10 mV		-	13	-	mV
		20 mV		-	23	-	mV
R _{lad}	ladder resistance	-		-	1	-	MΩ

[1] C_L = 10 pF

[2] Characterized on typical samples, not tested in production.

[3] Input hysteresis is relative to the reference input channel and is software programmable.

[4] 100 mV overdrive corresponds to a square wave from 50 mV below the reference (V_{IC}) to 50 mV above the reference.

Table 30. Comparator voltage ladder dynamic characteristics

 $T_{amb} = -40$ °C to +105 °C; $V_{DD} = 1.8$ V to 3.6 V.

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
t _{s(pu)}	power-up settling time	to 99% of voltage ladder output value	<u>[1]</u>	-	17	-	μS
t _{s(sw)}	switching settling time	to 99% of voltage ladder output value	<u>[1]</u>	-	18	-	μS

[1] Characterized on typical samples, not tested in production.

14.2 XTAL oscillator

In the XTAL oscillator circuit, only the crystal (XTAL) and the capacitances C_{X1} and C_{X2} need to be connected externally on XTALIN and XTALOUT. See Figure 37.



For best results, it is very critical to select a matching crystal for the on-chip oscillator. Load capacitance (CL), series resistance (RS), and drive level (DL) are important parameters to consider while choosing the crystal. After selecting the proper crystal, the external load capacitor C_{X1} and C_{X2} values can also be generally determined by the following expression:

 $C_{X1} = C_{X2} = 2C_L - (C_{Pad} + C_{Parasitic})$

Where:

C_L - Crystal load capacitance

 C_{Pad} - Pad capacitance of the XTALIN and XTALOUT pins (~3 pF).

C_{Parasitic} – Parasitic or stray capacitance of external circuit.

Although C_{Parasitic} can be ignored in general, the actual board layout and placement of external components influences the optimal values of external load capacitors. Therefore, it is recommended to fine tune the values of external load capacitors on actual hardware board to get the accurate clock frequency. For fine tuning, measure the clock on the XTALOUT pin and optimize the values of external load capacitors for minimum frequency deviation.

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HVQFN33: plastic thermal enhanced very thin quad flat package; no leads; 32 terminals; body 5 x 5 x 0.85 mm

Fig 42. Package outline HVQFN33 (5 x 5 x 0.85 mm)





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